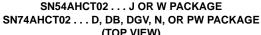
SCLS262D – DECEMBER 1995 – REVISED APRIL 1997

- Inputs Are TTL-Voltage Compatible
- *EPIC*[™] (Enhanced-Performance Implanted CMOS) Process
- High Latch-Up Immunity Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

description

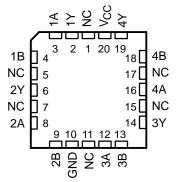
These devices contain four independent 2-input NOR gates that perform the Boolean function $Y = \overline{A} \cdot \overline{B}$ or $Y = \overline{A + B}$ in positive logic.

The SN54AHCT02 is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74AHCT02 is characterized for operation from -40° C to 85° C.



	(10	/	_ • •)	
1Y 1A	2		14 13] V _{CC}] 4Y
1B	3		12	[4В
2Y	4		11	4A
2A	5] 3Y
2B GND	6		9] 3B
GND	7		8] 3A

SN54AHCT02...FK PACKAGE (TOP VIEW)



NC - No internal connection

	(each g	ate)
INP	UTS	OUTPUT
Α	В	Y
Н	Х	L
Х	Н	L
L	L	н

FUNCTION TABLE



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

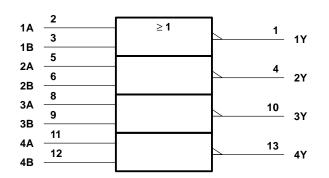
EPIC is a trademark of Texas Instruments Incorporated.

UNLESS OTHERWISE NOTED this document contains PRODUCTION DATA information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



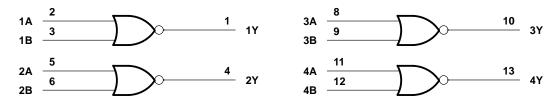
SCLS262D - DECEMBER 1995 - REVISED APRIL 1997

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

logic diagram (positive logic)



Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

Supply voltage range, V _{CC}		
Input voltage range, V _I (see Note 1)		
Output voltage range, VO (see Note 1)		
Input clamp current, IIK (VI < 0)		
Output clamp current, I_{OK} (V _O < 0 or V _O > V _C		
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$		
Continuous current through V _{CC} or GND		
Package thermal impedance, θ_{JA} (see Note 2)): D package	127°C/W
	DB package	158°C/W
	DGV package	182°C/W
	N package	
	PW package	170°C/W
Storage temperature range, T _{stg}		

[‡] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51, except for through-hole packages, which use a trace length of zero.



SCLS262D – DECEMBER 1995 – REVISED APRIL 1997

recommended operating conditions (see Note 3)

		SN54A	HCT02	ICT02 SN74AHCT02		UNIT
		MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V
VIH	High-level input voltage	2	N	2		V
V_{IL}	Low-level input voltage		0.8		0.8	V
VI	Input voltage	0	5.5	0	5.5	V
VO	Output voltage	0	Vcc	0	VCC	V
ЮН	High-level output current	UC	-8		-8	mA
IOL	Low-level output current	301	8		8	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	9	20		20	ns/V
Т _А	Operating free-air temperature	-55	125	-40	85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vaa	Τį	ן = 25°C	;	SN54AI	HCT02	SN74A	HCT02	UNIT
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
Veu	I _{OH} = -50 μA	4.5 V		4.5		4.4		4.4		V
Voh	$I_{OH} = -8 \text{ mA}$	4.5 V	3.94			3.8	Ŵ	3.8		v
Ve	I _{OL} = 50 μA	4.5 V			0.1		0.1		0.1	V
Vol	I _{OL} = 8 mA	4.5 V			0.36		0.44		0.44	v
Ц	$V_I = V_{CC}$ or GND	5.5 V			±0.1	1	× ±1		±1	μA
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			2	NC0	20		20	μA
∆lcc‡	One input at 3.4 V, Other inputs at GND or V _{CC}	5.5 V			1.35	PROI	1.5		1.5	mA
Ci	$V_I = V_{CC}$ or GND	5 V		4	10				10	pF

[†] This is the increase in supply current for each input at one of the specified TTL voltage levels rather than 0 V or V_{CC}.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER										
	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C			MIN		UNIT	
	(MIN	TYP	MAX	IVITIN	MAX		
^t PLH [*]	A or B	Y	Y	C _L = 15 pF		2.4	5.5	1	6.5	ns
^t PHL*	AUB			I	0L = 13 pi		3.5	5.5	1	6.5
^t PLH	A or B	v	C. = 50 pE		3.4	7.5	1	8.5	ns	
^t PHL	AUB	Ť	C _L = 50 pF		4.5	? 7.5	1	8.5	115	

* On products compliant to MIL-PRF-38535, this parameter is ensured but not production tested.



SCLS262D - DECEMBER 1995 - REVISED APRIL 1997

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C			MIN		UNIT	
	((6611 61)		MIN	TYP	MAX		MAX	L	
^t PLH	A or B	v	v	C _L = 15 pF		2.4	5.5	1	6.5	20
^t PHL	AOIB	I			3.5	5.5	1	6.5	ns	
^t PLH	A or B	v	V 0. 50 pF		3.4	7.5	1	8.5	ns	
^t PHL	AUB	ſ	C _L = 50 pF		4.5	7.5	1	8.5	115	

noise characteristics, $V_{CC} = 5 V$, $C_L = 50 pF$, $T_A = 25^{\circ}C$ (see Note 4)

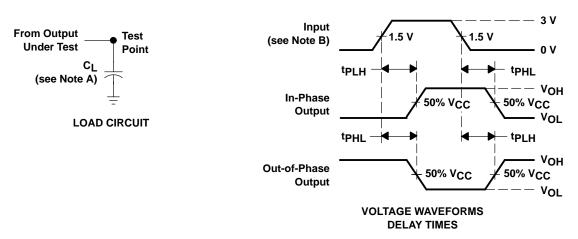
	PARAMETER SN74AHCT02		MIN TYP MAX 0.8 -0.8 4.7 2	UNIT	
	FARAMETER	MIN	TYP	MAX 0.8	UNIT
VOL(P)	Quiet output, maximum dynamic V _{OL}			0.8	V
VOL(V)	Quiet output, minimum dynamic V _{OL}			-0.8	V
VOH(V)	Quiet output, minimum dynamic V _{OH}		4.7		V
VIH(D)	High-level dynamic input voltage	2			V
V _{IL(D)}	Low-level dynamic input voltage			0.8	V

NOTE 4: Characteristics are determined during product characterization and ensured by design for surface-mount packages only.

operating characteristics, V_{CC} = 5 V, T_A = 25°C

	PARAMETER			TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	17	pF

PARAMETER MEASUREMENT INFORMATION



NOTES: A. C_L includes probe and jig capacitance.

- B. Input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_Q = 50 Ω , t_f = 3 ns, t_f = 3 ns.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.

Copyright © 1996, Texas Instruments Incorporated